# **Supporting Information**

## **Improved water oxidation with metal oxide catalysts via regenerable and redox-inactive ZnOxH<sup>y</sup> overlayer**

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#### **Experimental:**

#### **Fabrication** of  $\text{MO}_{\mathbb{Z}}/\text{ZnO}_x\text{H}_y$  (M= Co, Fe, Ni) :

Cobalt (II) chloride hexahydrate (CoCl<sub>2</sub>.6H<sub>2</sub>O) and iron (III) chloride hexahydrate (FeCl<sub>3</sub>.6H<sub>2</sub>O) were purchased from General reagent; Nickel (II) chloride hexahydrate NiCl<sub>2</sub>⋅6H<sub>2</sub>O was purchased from Kelong; Zinc(II) nitrate hexahydrate  $[Zn(NO<sub>3</sub>)<sub>2</sub>$ . 6H<sub>2</sub>O], was purchased from Adamas.

Bare FTO was exposed to UV light for 10 min before deposition. Each of the respective metal chloride precursors was dissolved into water to form a 0.2-1.0 M aqueoussolution. 1 mL metal precursorsolution was spin-coated each time onto FTO at 500 rpm for 10 seconds thrice followed by at 3000 rpm once for one minute.<sup>1</sup> After spin-coating, the films were left under a non-coherent UV lamp for 12 h to decompose chloride ligands. After UV treatment, the MO*<sup>z</sup>* films were annealed at a temperature with a range from 50-500 ℃.

#### **Electrochemical measurements:**

All electrochemical experiments were performed at room temperature (at 298 K) with a Bio-Logic SP-200 electrochemical workstation in a standard three-electrode system using FTO (F-doped SnO<sub>2</sub>) glass substrates as working electrode, a Pt wire as a counter electrode, and Ag/AgCl as a reference electrode. 1.0 M NaOH (pH 13.6 at 298 K) electrolyte solution was applied to measure OER performance of MO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* (M= Co and Fe) films. Whereas, 1.0 M Fe-free NaOH was prepared according to a reported procedure utilized as an electrolyte to measure OER performance of NiO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films.<sup>2</sup> Polarization curves were obtained using cyclic voltammetry with a scan rate of 10 mV/s. The Tafel slope was drawn from polarization curves. All potentials reported in this manuscript were converted to a reversible hydrogen electrode (RHE) using  $E_{RHE} = E_{Ag/AgCl} + (0.197 + 0.059 \times pH)$  V. The overpotentials were obtained using  $\eta = E_{RHE}$  - 1.23 V. Electrochemical impedance spectroscopy (EIS) was measured at potential 1.60 V vs RHE with a frequency scan range from 100 kHz to 1 mHz, and the amplitude of the sinusoidal wave was 10 mV.

#### **Physical Characterizations:**

The absorbance of the film was evaluated by QE Pro UV-visible spectrometer (Ocean Optics) equipped with an HL-2000 light source that connected via fiber-optic cables (200 μm fiber core diameter). The baseline was subtracted in each specific experiment. Atomic Co/Zn ratio and valence state of constituting elements of different CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films were confirmed by X-ray photoelectron spectroscopy on Escalab 250Xi and the binding energies were calibrated using the adventitious carbon by shifting the C1s peak to 284.8 eV. All XPS experiments were carried out by the Al K Alpha source gun and a constant spot size of 500 μm. The morphology of the catalyst films was examined by scanning electron microscope (SEM) and elemental mapping on FEI Inspect F50. The structure was further analyzed by high-resolution TEM (HRTEM). The elements mapping and the lattice planes are characterized by selected area electron diffraction (SAED) (FEI TECNAL G2 F30) field emission

transmission electron microscope. The mass content of Co and Zn in  $CoO_{z}/ZnO_{x}H_{y}$  catalyst film were analyzed by Inductively Coupled Plasma Mass Spectroscopy (ICP-MS) (Optima 7000DV).

# **Supplementary Figures:**



**Figure S1.** TEM and SAED patterns of CoO*<sup>z</sup>* films annealed at (a) 150 ℃, (b) 500 ℃ prepared from aqueous  $1.0 M CoCl<sub>2</sub>.6H<sub>2</sub>O$  precursor solution.



**Figure S2.** SEM images of CoO*<sup>z</sup>* films annealed at (a) 150 and (b) 500 ℃, respectively, prepared from aqueous 1.0 M CoCl<sub>2</sub>.6H<sub>2</sub>O precursor solution. Scale bar represents 1.0  $\mu$ m.



**Figure S3.** (a) CA with stepwise addition of Zn-anion solution measured at 1.6 V vs RHE and (b) CV curves of CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films where CoO*<sup>z</sup>* films onto FTO substrates were annealed at different temperatures. CoO<sub>z</sub> films were prepared from an aqueous 1.0 M CoCl<sub>2</sub>.6H<sub>2</sub>O precursor solution.



**Figure S4**. Cross-sectional SEM images of bare FTO,  $CoO<sub>z</sub>$  and  $CoO<sub>z</sub>/ZnO<sub>y</sub>H<sub>z</sub>$  films.



**Figure S5**. The Co and Zn content in CoO<sub>z</sub>/ZnO<sub>x</sub>H<sub>y</sub> film was analyzed by Inductively Coupled Plasma Mass Spectroscopy (ICP-MS) (Optima 7000DV). The as-prepared CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* catalyst film was put into HNO<sub>3</sub> for 24 hours to ensure complete dissolution which was further diluted to perform the analysis.



**Figure S6.** The XPS spectra of  $CoO_Z/ZnO_yH_z$  films.



**Figure S7.** Co 2p XPS spectra of bare CoO<sub>z</sub> and CoO<sub>z</sub>/ZnO<sub>x</sub>H<sub>y</sub>.



**Figure S8.** Chronopotentiometric (CP) curves of CoO*<sup>z</sup>* films annealed at (a) 150 ℃, and (b) 300 ℃, respectively, with stepwise addition of  $[Zn(OH)_4]^2$  solution operating at 1.0 mA/cm<sup>2</sup>.



**Figure S9.** XPS spectra of CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films while using different current densities to deposit ZnO*x*H*<sup>y</sup>* onto CoO*<sup>z</sup>* surface.

**Table S1.** Atomic Co/Zn ratio of CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films while using different current densities to deposit ZnO*x*H*<sup>y</sup>* layer onto CoO*<sup>z</sup>* surface.

| Current density ( $mA \text{ cm}^{-2}$ ) | Surface Co/Zn ratio |
|--|---------------------|
| 1.0                                      | 21.24               |
| 10.0                                     | 12.29               |
| 20.0                                     | 10.69               |



**Figure S10.** CV curves of CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films while using different current densities to deposit ZnO*x*H*<sup>y</sup>* layer onto CoO*<sup>z</sup>* surface.



**Figure S11.** Tafel slopes of (a)  $CoO_z$ , (b)  $CoZnO_xH_y$ , and (c)  $CoO_z/ZnO_xH_y$  films.



**Figure S12.** Charge transfer of (a)  $CoO_z$ , and (b)  $CoO_z/ZnO_xH_y$  films. Inset shows the electrical equivalent circuit.



**Figure S13.** Photograph of home-made cell for in-situ spectroelectrochemical UV-vis setup.



**Figure S14.** In-situ UV-vis absorbance of (A) CoO*<sup>z</sup>* , and (B) CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films at different potentials measured during OER**.**



**Figure S15**. CA curve was recorded at 1.6 V vs RHE upon addition of Zn-anion on NiFeOOH catalyst. The NiFeOOH catalyst film was synthesized by hydrothermal method according to previously reported work.<sup>3</sup>



**Figure S16.** Long-term stability measurement of the bare  $CoO<sub>z</sub>$  and  $CoO<sub>z</sub>/ZnO<sub>x</sub>H<sub>y</sub>$  films operating at 1.0 mA/cm<sup>2</sup> . Asterisks (\*) on the curve for the CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* indicate an extra addition of 0.1  $\mu$ M [Zn(OH)<sub>4</sub>]<sup>2-</sup> into the electrolyte.



**Figure S17.** XPS spectra of CoO*<sup>z</sup>* /ZnO*x*H*<sup>y</sup>* films during stability experiment after 10 h and 100 h.

#### **References**

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